TOSHIBA Photocoupler GaAlAs IRed & Photo-IC

TLP651

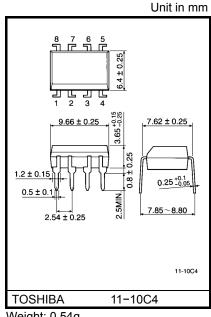
Digital Logic Ground Isolation Line Receiver Microprocessor System Interfaces Switching Power Supply Feedback Control Analog Signal Isolation

The TOSHIBA TLP651 consists of a GaAlAs high-output light emitting diode and a high speed detector of one chip photo diode-transistor. This unit is 8-lead DIP.

TLP651 has internal base connection. This base pin should be used for analog application or enable operation. If base pin is open, output signal will be noisy by environmental condition. For this case, TLP650 is suitable.

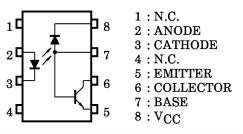
- Isolation voltage: 5000V_{rms} (min.)
 - Switching speed: t_{pHL} = 0.3µs (typ.)
 - $t_{pLH} = 0.5 \mu s$ (typ.) (R_L = 1.9k Ω)
- TTL compatible •
- UL recognized: UL1577, file no. E67349
- BSI approved: BS EN60065: 2002

Certificate no. 7613 BS EN60950-1: 2002 Certificate no. 7614

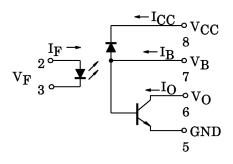


Weight: 0.54g

Pin Configuration (top view)



Schematic



Absolute Maximum Ratings (Ta = 25°C)

	Characteristic		Symbol	Rating	Unit
	Forward current	(Note 1)	١ _F	25	mA
	Pulse forward current	(Note 2)	I _{FP}	50	mA
LED	Peak transient forward current	(Note 3)	IFPT	1	А
	Reverse voltage		V _R	5	V
	Diode power dissipation	(Note 4)	PD	45	mW
	Output current		Ι _Ο	8	mA
	Peak output current		I _{OP}	16	mA
ŗ	Output voltage		VO	-0.5~15	V
Detector	Supply voltage		V _{CC}	-0.5~15	V
ă	Base current		Ι _Β	5	mA
	Emitter-base reverse voltage		V _{EB}	5	V
	Output power dissipation	(Note 5)	PO	100	mW
Ope	erating temperature range		T _{opr}	-55~100	°C
Stor	age temperature range		T _{stg}	-55~125	°C
Lea	d solder temperature (10s)	(Note 6)	T _{sol}	260	°C
Isol (AC	ation voltage , 1min., R.H.≤ 60%)	(Note 7)	BVS	5000	V _{rms}

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- (Note 1) Derate 0.8mA above 70°C.
- (Note 2) 50% duty cycle,1ms pulse width. Derate 1.6mA / °C above 70°C.
- (Note 3) Pulse width \leq 1µs, 300pps.
- (Note 4) Derate 0.9mW / °C above 70°C.
- (Note 5) Derate 2mW / °C above 70°C.
- (Note 6) Soldering portion of lead: Up to 2mm from the body of the device.
- (Note 7) Device considered a two terminal device: Pins 1, 2, 3 and 4 shorted together and pins 5, 6, 7 and 8 shorted together.

Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition			Min.	Тур.	Max.	Unit
	Forward voltage	V _F	I _F = 16mA	—	1.65	1.85	V		
LED	Forward voltage temperature coefficient	ΔV _F / ΔTa	I _F = 16mA	_	-2	_	mV / °C		
	Reverse current	I _R	V _R = 5V	_		10	μA		
	Capacitance between terminal	CT	V _F = 0, f = 1MHz	_	45	_	pF		
Detector	High level output current	IOH (1)	I _F = 0mA, V _{CC} = '	_	3	500	nA		
		I _{OH (2)}	I _F = 0mA, V _{CC} = '	_	-	5	μA		
		IOH	I _F = 0mA, V _{CC} = V Ta = 70°C	_	_	250	μA		
	High level supply voltage	ICCH	I _F = 0mA, V _{CC} =	_	0.01	1	μA		
	Current transfer ratio	IO / IF		Ta = 25°C		10	30	_	
			I _F = 16mA V _{CC} = 4.5V V _O = 0.4V		Rank: O	19	30	_	%
				Ta = 0~70°C		5		_	70
σ					Rank: O	15	_	_	
Coupled	Low level output voltage	V _{OL}	I _F = 16mA, V _{CC} = I _O = 1.1mA (Rank 0: I _O = 2.4	_	_	0.4	v		
	Isolation resistance	R _S	R.H.≤ 60%, V _S =	5×10 ¹⁰	10 ¹⁴	_	Ω		
	Capacitance between input to output	CS	V _S = 0, f = 1MHz (Note 7)			_	0.8	_	pF

Switching Characteristics (Ta = 25°C, V_{CC} = 5V)

Characteristic		Symbol	Test Cir– cuit	Test Condition		Min.	Тур.	Max.	Unit	
Propagation delay time		t _{pHL}	1	$I_F = 0 \rightarrow 16 \text{mA}, V_{CC} = 5 \text{V},$		_	0.2	0.8	116	
(H→L)				R_L =4.1k Ω	Rank O: RL=1.9kΩ	_	0.3	0.8	μs	
Propagation delay time		t		I _F = 16→ 0)mA, V _{CC} = 5V,	—	1.0	2.0	110	
(L→H)		^t pLH		R_L =4.1k Ω	Rank O: RL=1.9kΩ	—	0.5	1.2	μs	
Common mode transient immunity at logic high output	(Note 8)	C _{MH}	2	I _F = 0mA, V _{CM} = 200V _{p-p} R _L = 4.1kΩ (Rank O: R _L = 1.9kΩ)		_	400	_	V / µs	
Common mode transient immunity at logic low output	(Note 8)	C _{ML}	2	I _F =16mA, V _{CM} = 200V _{p-p} R _L = 4.1kΩ (Rank O: R _L = 1.9kΩ)		_	-1000	_	V / µs	

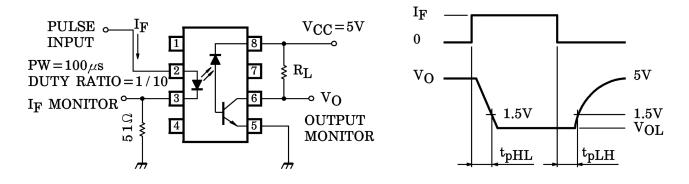
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(Note 8) CM_L is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic low state ($V_O < 0.8V$).

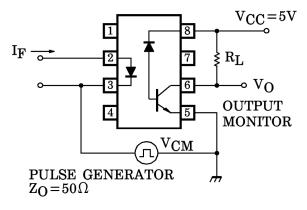
 CM_H is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic high state (V_O > 2.0V).

(Note 9) Maximum electrostatic discharge voltage for any pins: 100V (C = 200pF, R = 0).

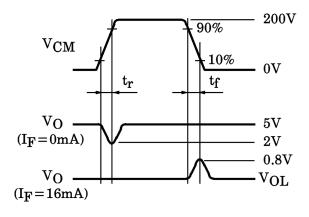
Test Circuit 1: Switching Time Test Circuit



Test Circuit 2: Common Mode Noise Immunity Test Circuit



$$\mathrm{CM}_{\mathrm{H}} = \frac{160 \, \mathrm{(V)}}{\mathrm{t}_{\mathrm{r}} \, (\mu \mathrm{s})}$$
, $\mathrm{CM}_{\mathrm{L}} = \frac{160 \, \mathrm{(V)}}{\mathrm{t}_{\mathrm{f}} \, (\mu \mathrm{s})}$



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3 5

5

 $\mathbf{20}$

10

Ta = 25°C

10

100°C

-25°C

30 50 100

NORMALIZED

 $I_F = 16 m A$ $V_{\rm CC} = 4.5 V$

 $V_0 = 0.4V$ $Ta = 25^{\circ}C$

60

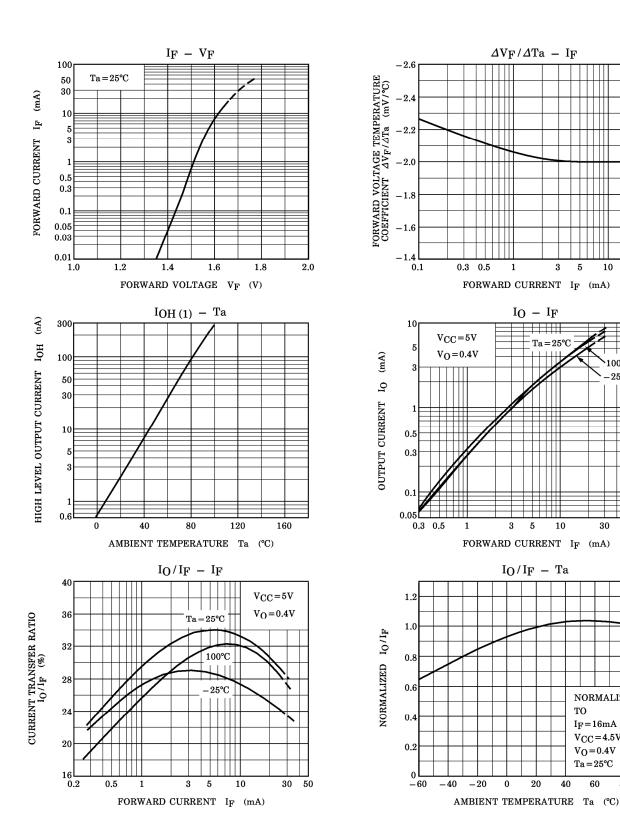
80

100

то

40

30



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 $V_{CC} = 5V$

-0

٧o

14

16

≱RL

VO - IF

 $R_L = 2k\Omega$

.9k Ω

4

6

8

FORWARD CURRENT IF (mA)

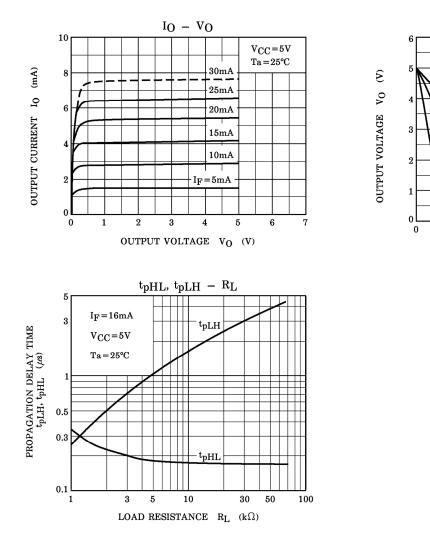
2

IF

/┿ Ta=25℃

10

12



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